

## INSULATED GATE BIPOLAR TRANSISTOR WITH ULTRAFAST SOFT RECOVERY DIODE

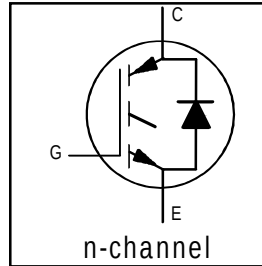
Fast CoPack IGBT

### Features

- Fast: Optimized for medium operating frequencies ( 1-5 kHz in hard switching, >20 kHz in resonant mode).
- Generation 4 IGBT design provides tighter parameter distribution and higher efficiency than Generation 3
- IGBT co-packaged with HEXFRED™ ultrafast, ultra-soft-recovery anti-parallel diodes for use in bridge configurations
- Industry standard TO-220AB package

### Benefits

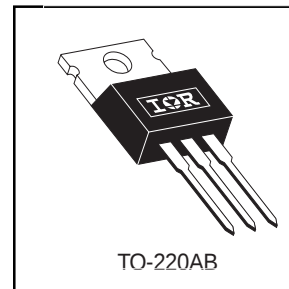
- Generation -4 IGBT's offer highest efficiencies available
- IGBT's optimized for specific application conditions
- HEXFRED diodes optimized for performance with IGBT's . Minimized recovery characteristics require less/no snubbing
- Designed to be a "drop-in" replacement for equivalent industry-standard Generation 3 IR IGBT's



$$V_{CES} = 600V$$

$$V_{CE(on)} \text{ typ.} = 1.59V$$

$$@V_{GE} = 15V, I_C = 17A$$



### Absolute Maximum Ratings

|                           | Parameter                          | Max.                              | Units      |
|---------------------------|------------------------------------|-----------------------------------|------------|
| $V_{CES}$                 | Collector-to-Emitter Voltage       | 600                               | V          |
| $I_C @ T_C = 25^\circ C$  | Continuous Collector Current       | 31                                | A          |
| $I_C @ T_C = 100^\circ C$ | Continuous Collector Current       | 17                                |            |
| $I_{CM}$                  | Pulsed Collector Current ①         | 120                               |            |
| $I_{LM}$                  | Clamped Inductive Load Current ②   | 120                               |            |
| $I_F @ T_C = 100^\circ C$ | Diode Continuous Forward Current   | 12                                |            |
| $I_{FM}$                  | Diode Maximum Forward Current      | 120                               | V          |
| $V_{GE}$                  | Gate-to-Emitter Voltage            | $\pm 20$                          |            |
| $P_D @ T_C = 25^\circ C$  | Maximum Power Dissipation          | 100                               | W          |
| $P_D @ T_C = 100^\circ C$ | Maximum Power Dissipation          | 42                                |            |
| $T_J$                     | Operating Junction and             | -55 to +150                       | $^\circ C$ |
| $T_{STG}$                 | Storage Temperature Range          |                                   |            |
|                           | Soldering Temperature, for 10 sec. | 300 (0.063 in. (1.6mm) from case) |            |
|                           | Mounting Torque, 6-32 or M3 Screw. | 10 lbf•in (1.1 N•m)               |            |

### Thermal Resistance

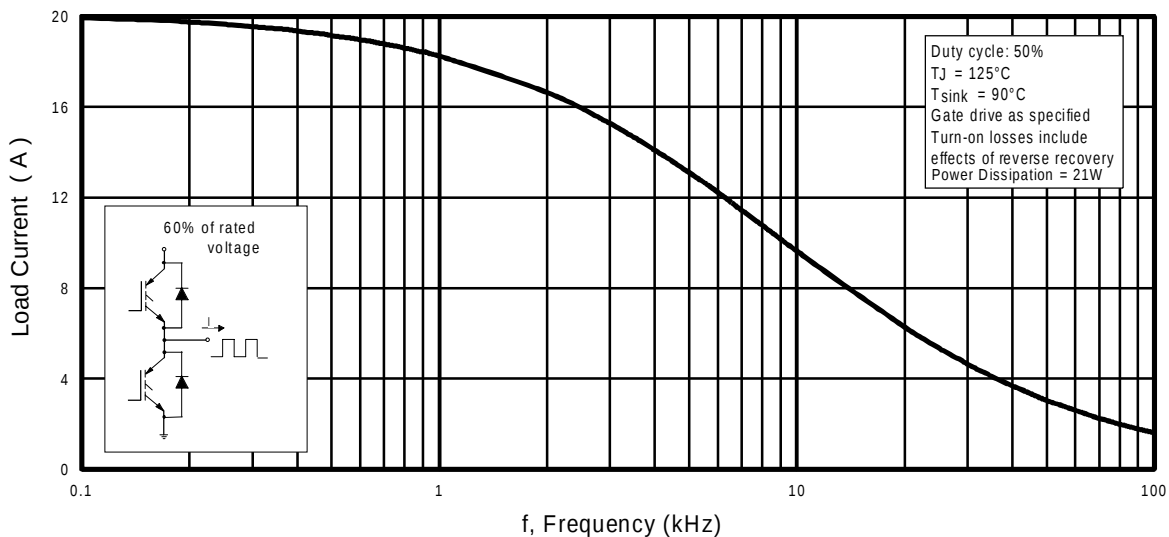
|                 | Parameter                                 | Min.  | Typ.     | Max.  | Units        |
|-----------------|-------------------------------------------|-------|----------|-------|--------------|
| $R_{\theta JC}$ | Junction-to-Case - IGBT                   | ----- | -----    | 1.2   | $^\circ C/W$ |
| $R_{\theta JC}$ | Junction-to-Case - Diode                  | ----- | -----    | 2.5   |              |
| $R_{\theta CS}$ | Case-to-Sink, flat, greased surface       | ----- | 0.50     | ----- |              |
| $R_{\theta JA}$ | Junction-to-Ambient, typical socket mount | ----- | -----    | 80    |              |
| $W_t$           | Weight                                    | ----- | 2 (0.07) | ----- | g (oz)       |

## Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

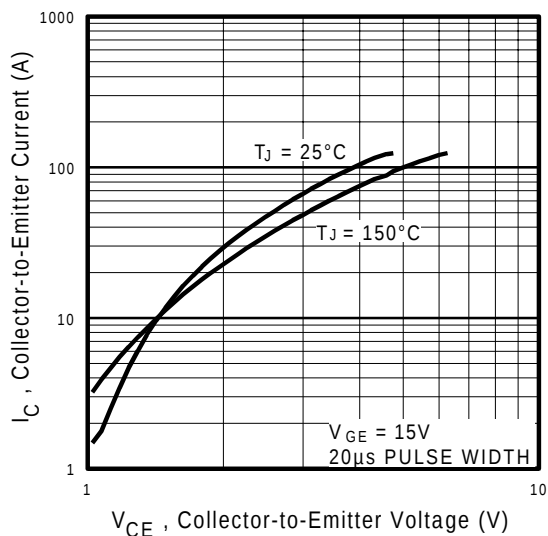
|                     | Parameter                                           | Min. | Typ. | Max.      | Units                | Conditions                                            |
|---------------------|-----------------------------------------------------|------|------|-----------|----------------------|-------------------------------------------------------|
| $V_{(BR)CES}$       | Collector-to-Emitter Breakdown Voltage <sup>③</sup> | 600  | ---- | ----      | V                    | $V_{GE} = 0V, I_C = 250\mu A$                         |
| $DV_{(BR)CES}/DT_J$ | Temperature Coeff. of Breakdown Voltage             | ---- | 0.69 | ----      | V/ $^\circ\text{C}$  | $V_{GE} = 0V, I_C = 1.0mA$                            |
| $V_{CE(on)}$        | Collector-to-Emitter Saturation Voltage             | ---- | 1.59 | 1.8       | V                    | $I_C = 17A, V_{GE} = 15V$                             |
|                     |                                                     | ---- | 1.99 | ----      |                      | $I_C = 31A$ See Fig. 2, 5                             |
|                     |                                                     | ---- | 1.70 | ----      |                      | $I_C = 17A, T_J = 150^\circ\text{C}$                  |
| $V_{GE(th)}$        | Gate Threshold Voltage                              | 3.0  | ---- | 6.0       |                      | $V_{CE} = V_{GE}, I_C = 250\mu A$                     |
| $DV_{GE(th)}/DT_J$  | Temperature Coeff. of Threshold Voltage             | ---- | -11  | ----      | mV/ $^\circ\text{C}$ | $V_{CE} = V_{GE}, I_C = 250\mu A$                     |
| $g_{fe}$            | Forward Transconductance <sup>④</sup>               | 6.1  | 10   | ----      | S                    | $V_{CE} = 100V, I_C = 17A$                            |
| $I_{CES}$           | Zero Gate Voltage Collector Current                 | ---- | ---- | 250       | $\mu A$              | $V_{GE} = 0V, V_{CE} = 600V$                          |
|                     |                                                     | ---- | ---- | 2500      |                      | $V_{GE} = 0V, V_{CE} = 600V, T_J = 150^\circ\text{C}$ |
| $V_{FM}$            | Diode Forward Voltage Drop                          | ---- | 1.4  | 1.7       | V                    | $I_C = 12A$ See Fig. 13                               |
|                     |                                                     | ---- | 1.3  | 1.6       |                      | $I_C = 12A, T_J = 150^\circ\text{C}$                  |
| $I_{GES}$           | Gate-to-Emitter Leakage Current                     | ---- | ---- | $\pm 100$ | nA                   | $V_{GE} = \pm 20V$                                    |

## Switching Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

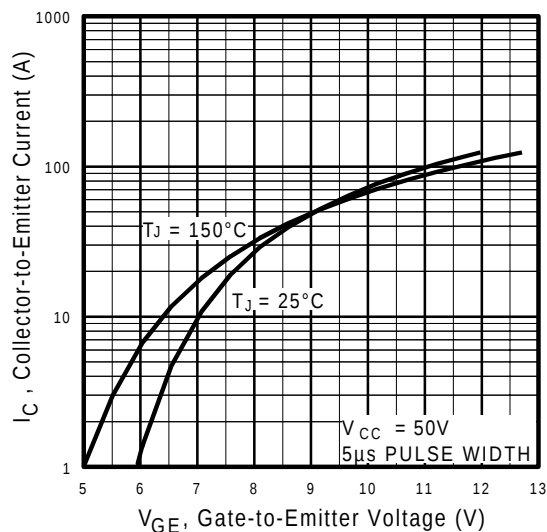
|                  | Parameter                                        | Min. | Typ. | Max. | Units      | Conditions                                               |
|------------------|--------------------------------------------------|------|------|------|------------|----------------------------------------------------------|
| $Q_g$            | Total Gate Charge (turn-on)                      | ---- | 51   | 77   | nC         | $I_C = 17A$                                              |
| $Q_{ge}$         | Gate - Emitter Charge (turn-on)                  | ---- | 7.9  | 12   |            | $V_{CC} = 400V$ See Fig. 8                               |
| $Q_{gc}$         | Gate - Collector Charge (turn-on)                | ---- | 19   | 28   |            | $V_{GE} = 15V$                                           |
| $t_{d(on)}$      | Turn-On Delay Time                               | ---- | 42   | ---- | ns         | $T_J = 25^\circ\text{C}$                                 |
| $t_r$            | Rise Time                                        | ---- | 26   | ---- |            | $I_C = 17A, V_{CC} = 480V$                               |
| $t_{d(off)}$     | Turn-Off Delay Time                              | ---- | 230  | 350  |            | $V_{GE} = 15V, R_G = 23\Omega$                           |
| $t_f$            | Fall Time                                        | ---- | 160  | 230  | mJ         | Energy losses include "tail" and diode reverse recovery. |
| $E_{on}$         | Turn-On Switching Loss                           | ---- | 0.63 | ---- |            | See Fig. 9, 10, 11, 18                                   |
| $E_{off}$        | Turn-Off Switching Loss                          | ---- | 1.39 | ---- |            |                                                          |
| $E_{ts}$         | Total Switching Loss                             | ---- | 2.02 | 3.9  | mJ         | $T_J = 150^\circ\text{C}$ , See Fig. 9, 10, 11, 18       |
| $t_{d(on)}$      | Turn-On Delay Time                               | ---- | 42   | ---- |            | $I_C = 17A, V_{CC} = 480V$                               |
| $t_r$            | Rise Time                                        | ---- | 27   | ---- |            | $V_{GE} = 15V, R_G = 23\Omega$                           |
| $t_{d(off)}$     | Turn-Off Delay Time                              | ---- | 310  | ---- | mJ         | Energy losses include "tail" and diode reverse recovery. |
| $t_f$            | Fall Time                                        | ---- | 310  | ---- |            |                                                          |
| $E_{ts}$         | Total Switching Loss                             | ---- | 3.2  | ---- |            |                                                          |
| $L_E$            | Internal Emitter Inductance                      | ---- | 7.5  | ---- | nH         | Measured 5mm from package                                |
| $C_{ies}$        | Input Capacitance                                | ---- | 1100 | ---- | pF         | $V_{GE} = 0V$                                            |
| $C_{oes}$        | Output Capacitance                               | ---- | 74   | ---- |            | $V_{CC} = 30V$ See Fig. 7                                |
| $C_{res}$        | Reverse Transfer Capacitance                     | ---- | 14   | ---- |            | $f = 1.0MHz$                                             |
| $t_{rr}$         | Diode Reverse Recovery Time                      | ---- | 42   | 60   | ns         | $T_J = 25^\circ\text{C}$ See Fig. 14                     |
|                  |                                                  | ---- | 80   | 120  |            | $T_J = 125^\circ\text{C}$                                |
| $I_{rr}$         | Diode Peak Reverse Recovery Current              | ---- | 3.5  | 6.0  | A          | $T_J = 25^\circ\text{C}$ See Fig. 15                     |
|                  |                                                  | ---- | 5.6  | 10   |            | $T_J = 125^\circ\text{C}$                                |
| $Q_{rr}$         | Diode Reverse Recovery Charge                    | ---- | 80   | 180  | nC         | $T_J = 25^\circ\text{C}$ See Fig. 16                     |
|                  |                                                  | ---- | 220  | 600  |            | $T_J = 125^\circ\text{C}$                                |
| $di_{(rec)M}/dt$ | Diode Peak Rate of Fall of Recovery During $t_b$ | ---- | 180  | ---- | A/ $\mu s$ | $T_J = 25^\circ\text{C}$ See Fig. 17                     |
|                  |                                                  | ---- | 120  | ---- |            | $T_J = 125^\circ\text{C}$                                |



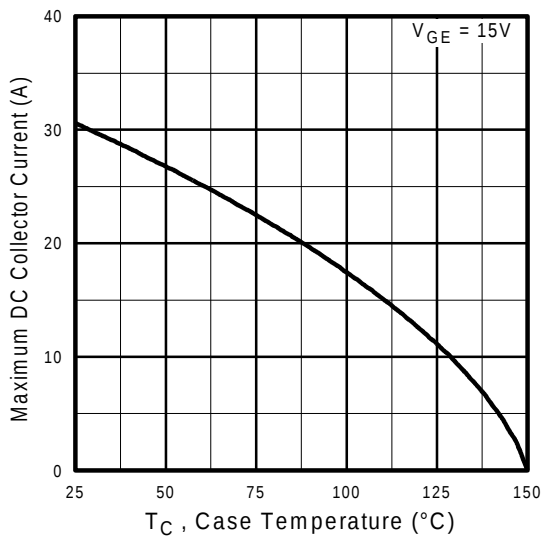
**Fig. 1 - Typical Load Current vs. Frequency**  
 (Load Current =  $I_{\text{RMS}}$  of fundamental)



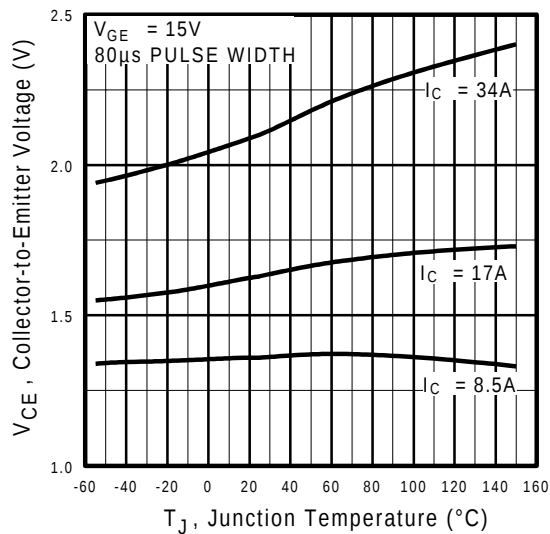
**Fig. 2 - Typical Output Characteristics**



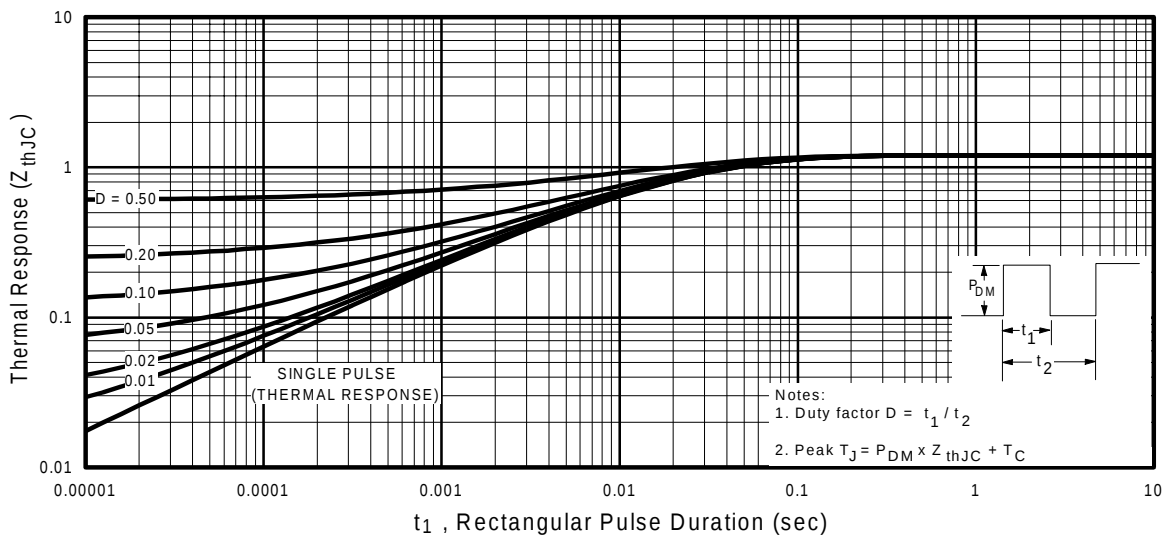
**Fig. 3 - Typical Transfer Characteristics**



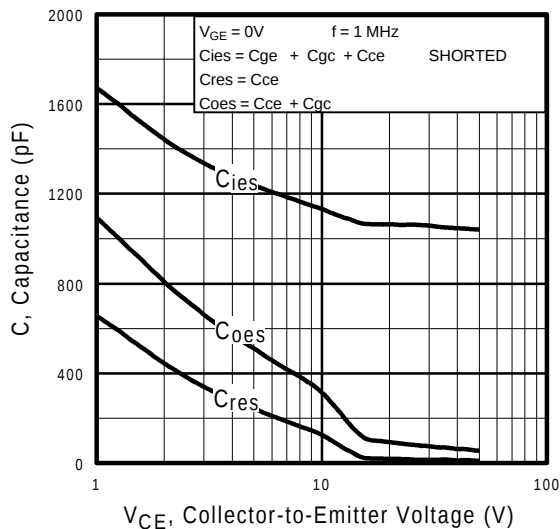
**Fig. 4** - Maximum Collector Current vs. Case Temperature



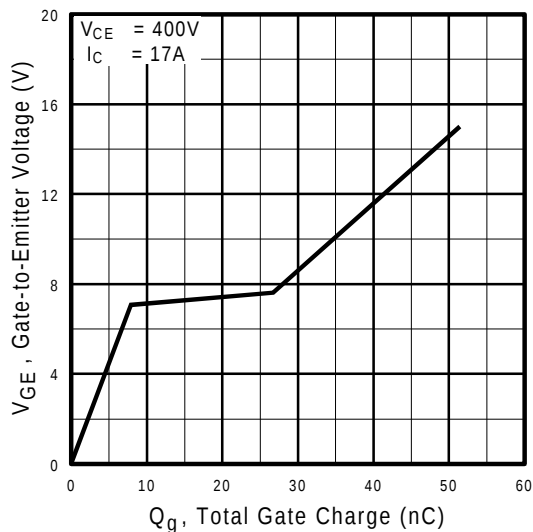
**Fig. 5** - Typical Collector-to-Emitter Voltage vs. Junction Temperature



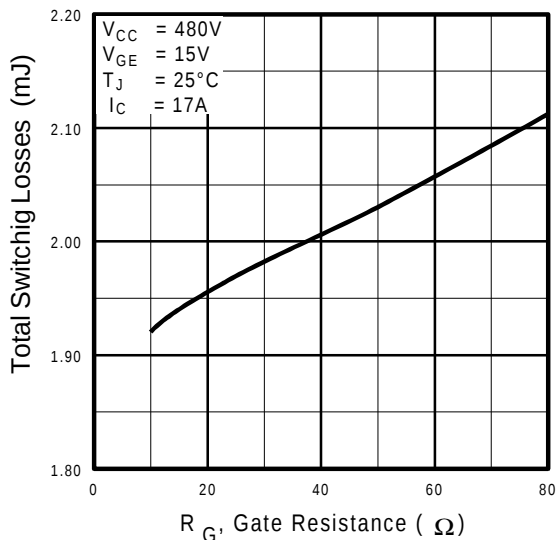
**Fig. 6** - Maximum Effective Transient Thermal Impedance, Junction-to-Case



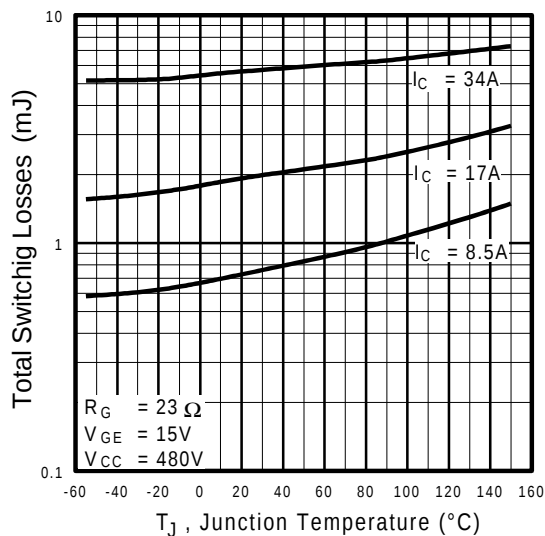
**Fig. 7** - Typical Capacitance vs. Collector-to-Emitter Voltage



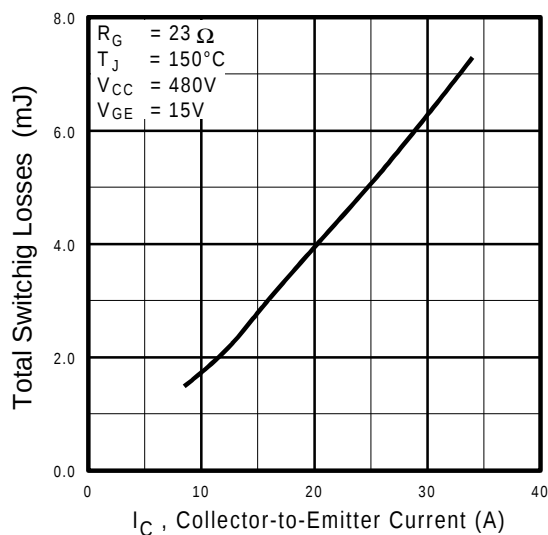
**Fig. 8** - Typical Gate Charge vs. Gate-to-Emitter Voltage



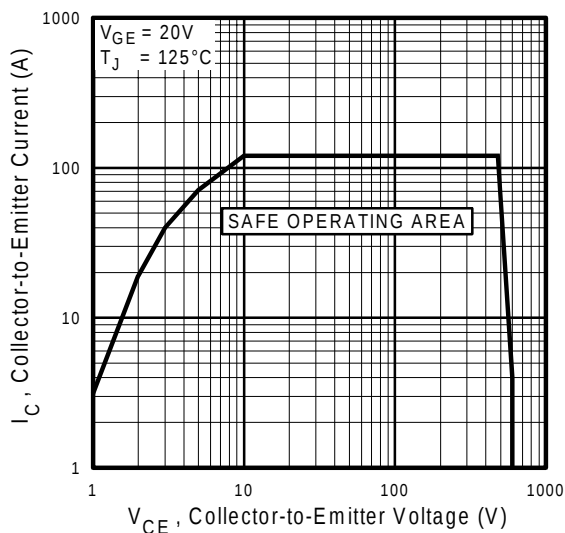
**Fig. 9** - Typical Switching Losses vs. Gate Resistance



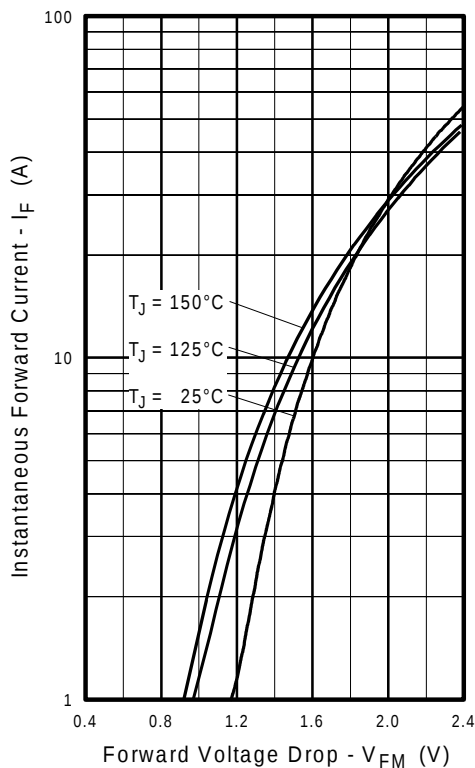
**Fig. 10** - Typical Switching Losses vs. Junction Temperature



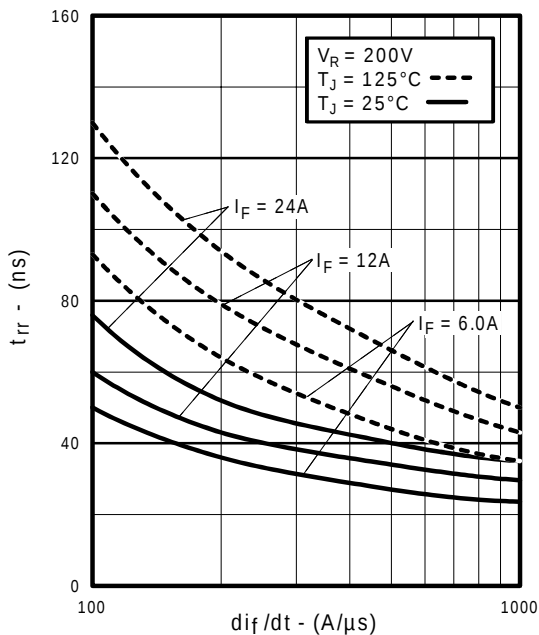
**Fig. 11** - Typical Switching Losses vs. Collector-to-Emitter Current



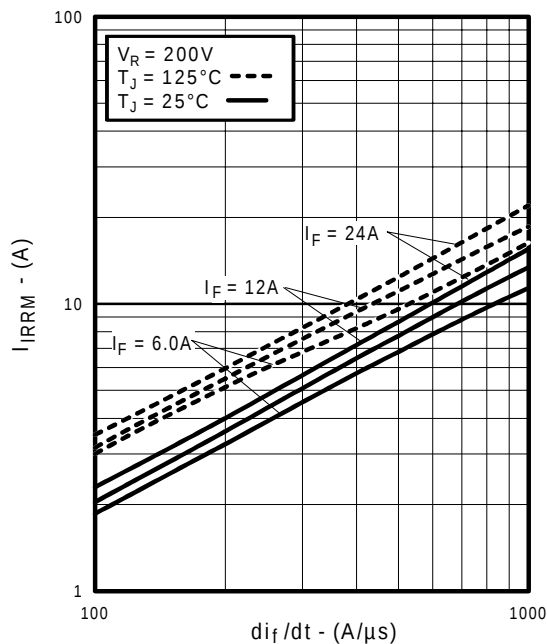
**Fig. 12** - Turn-Off SOA



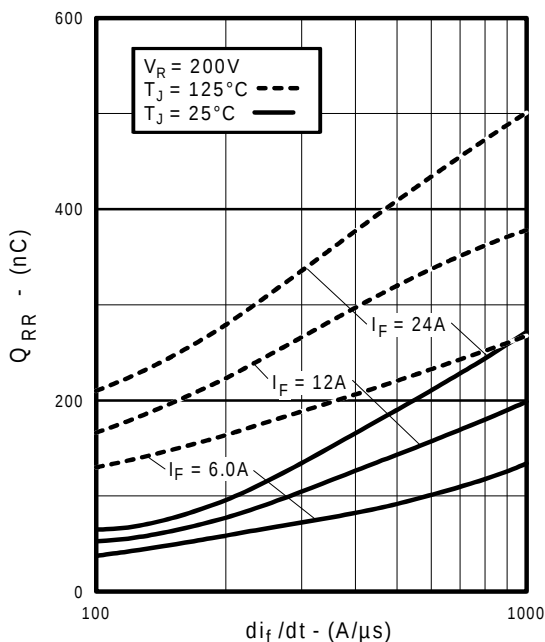
**Fig. 13** - Maximum Forward Voltage Drop vs. Instantaneous Forward Current



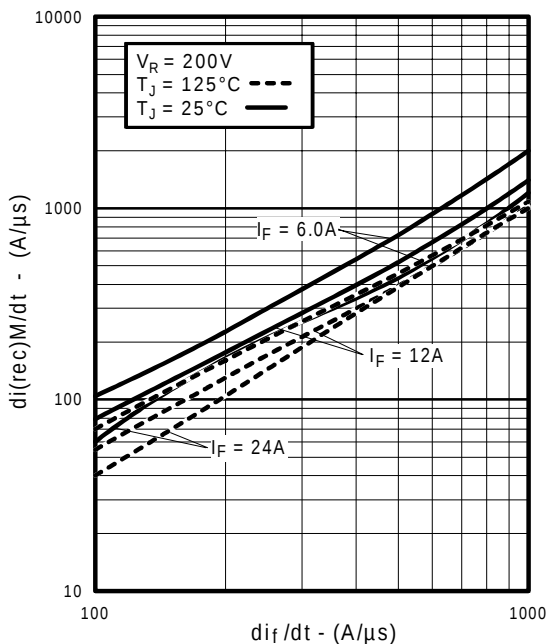
**Fig. 14** - Typical Reverse Recovery vs.  $di_f/dt$



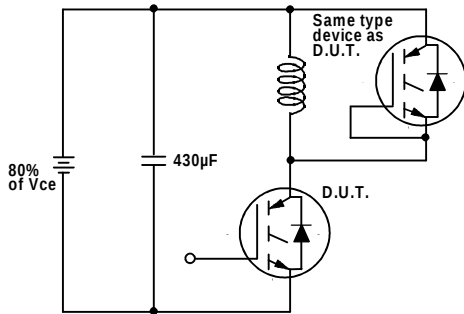
**Fig. 15** - Typical Recovery Current vs.  $di_f/dt$



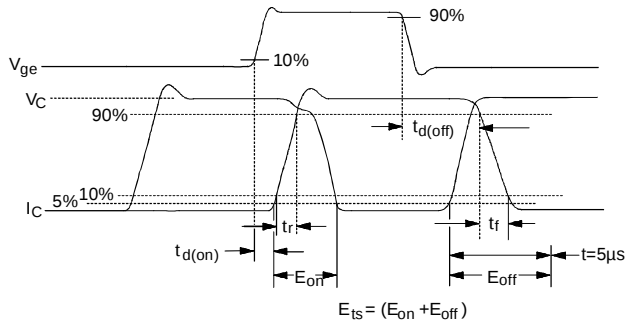
**Fig. 16** - Typical Stored Charge vs.  $di_f/dt$



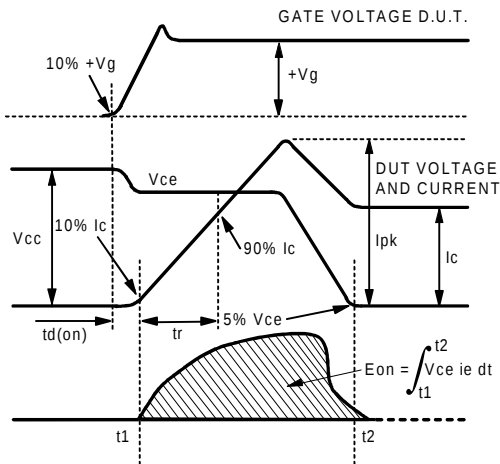
**Fig. 17** - Typical  $di_{(rec)}M/dt$  vs.  $di_f/dt$



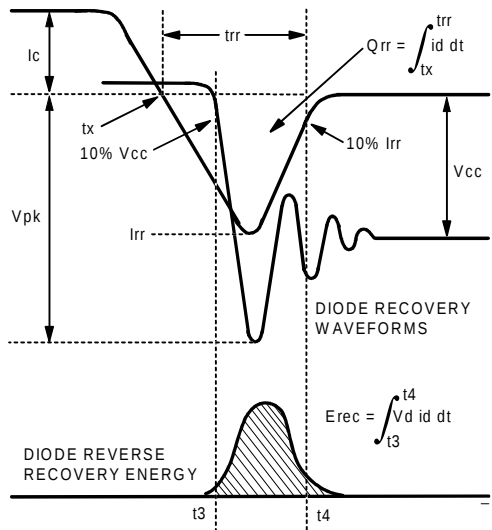
**Fig. 18a** - Test Circuit for Measurement of  $I_{LM}$ ,  $E_{on}$ ,  $E_{off}(\text{diode})$ ,  $t_{rr}$ ,  $Q_{rr}$ ,  $I_{rr}$ ,  $t_{d(on)}$ ,  $t_r$ ,  $t_{d(off)}$ ,  $t_f$



**Fig. 18b** - Test Waveforms for Circuit of Fig. 18a, Defining  $E_{off}$ ,  $t_{d(off)}$ ,  $t_f$



**Fig. 18c** - Test Waveforms for Circuit of Fig. 18a, Defining  $E_{on}$ ,  $t_{d(on)}$ ,  $t_r$



**Fig. 18d** - Test Waveforms for Circuit of Fig. 18a, Defining  $E_{rec}$ ,  $t_{rr}$ ,  $Q_{rr}$ ,  $I_{rr}$

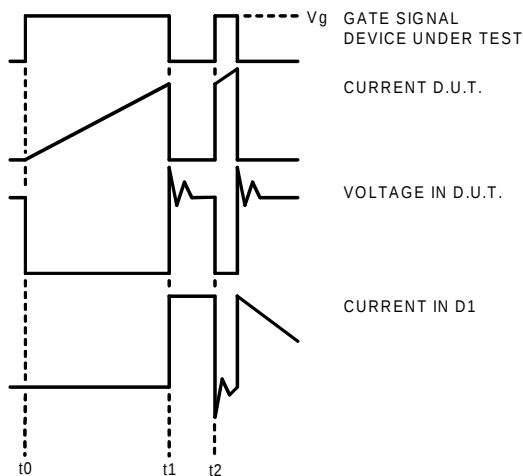


Figure 18e. Macro Waveforms for Figure 18a's Test Circuit

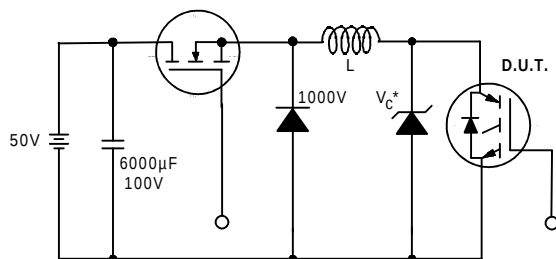


Figure 19. Clamped Inductive Load Test Circuit

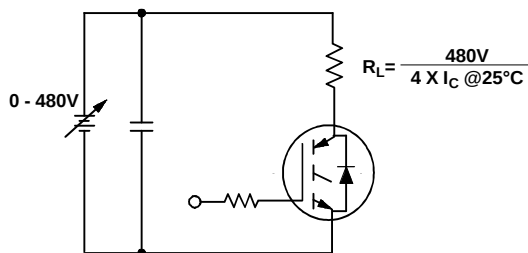


Figure 20. Pulsed Collector Current Test Circuit

## Notes:

- ① Repetitive rating:  $V_{GE}=20V$ ; pulse width limited by maximum junction temperature (figure 20)
- ②  $V_{CC}=80\%(V_{CES})$ ,  $V_{GE}=20V$ ,  $L=10\mu H$ ,  $R_G = 23W$  (figure 19)
- ③ Pulse width  $\leq 80\mu s$ ; duty factor  $\leq 0.1\%$ .
- ④ Pulse width  $5.0\mu s$ , single shot.

## Case Outline — TO-220AB

